Searcl	h Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/534,119	IHS ET AL.
Examiner	Art Unit
Linh V. Nguyen	2819

	SEARCHED				
Class	Subclass	Date	Examiner		
341	118,120, 143,155	10/29/2006	LN		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR	NOTES CH STRATEG	Y)
	DATE	EXMR
East see search printout	11/29/2006	LN